



#### **COMPLEMENTARY 60V ENHANCEMENT MODE MOSFET**

#### **Product Summary**

Device	V <sub>(BR)DSS</sub>	R <sub>DS(on) max</sub>	I <sub>D</sub> T <sub>A</sub> = +25°C
Q2	60V	55mΩ @ V <sub>GS</sub> = 10V	4.7A
Q1	-60V	105mΩ @ V <sub>GS</sub> = -10V	-3.9A

#### **Description**

This new generation MOSFET has been designed to minimize the onstate resistance ( $R_{DS(on)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

#### **Applications**

- DC-DC Converters
- Power Management Functions
- Backlighting

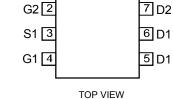
#### **Features and Benefits**

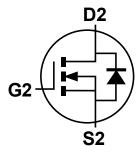
- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

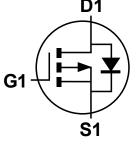
#### **Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish annealed over Copper leadframe Solderable per MIL-STD-202, Method 208
- Weight: 0.074 grams (approximate)









Top View

TOP VIEW Internal Schematic

N-Channel MOSFET

P-Channel MOSFET

#### Ordering Information (Note 4)

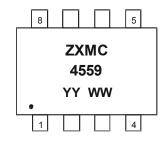
Part Number	Compliance	Case	Packaging
ZXMC4559DN8TA	Standard	SO-8	500/Tape & Reel
ZXMC4559DN8TC	Standard	SO-8	2,500/Tape & Reel

8 D2

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

### **Marking Information**



ZXMC4559 = Product Type Marking Code YYWW = Date Code Marking YY = Year (ex: 14 = 2014) WW = Week (01 - 53)



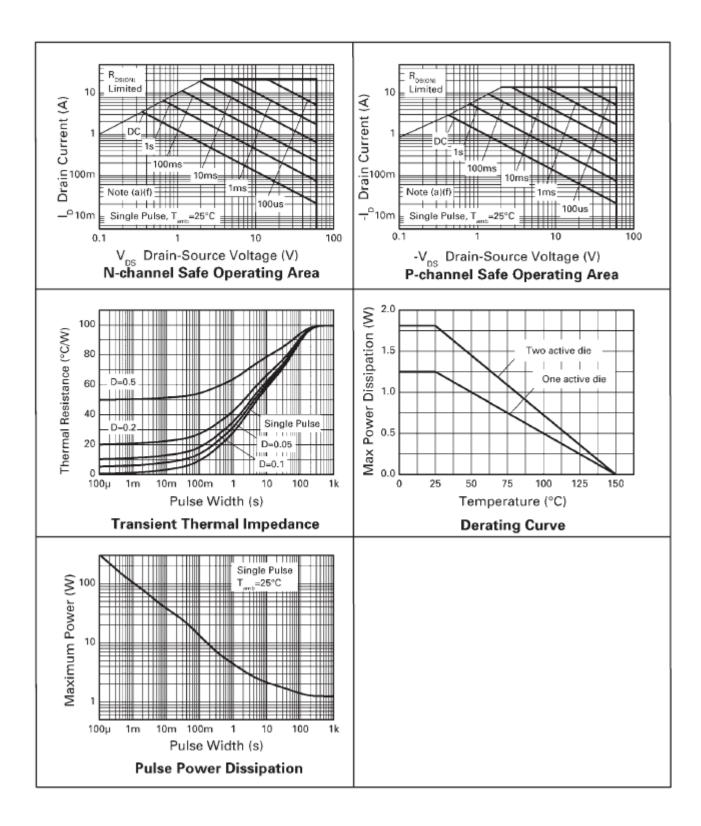
# **Maximum Ratings** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value_Q2	Value_Q1	Units	
Drain-Source Voltage	V <sub>DSS</sub>	60	-60	V	
Gate-Source Voltage	V <sub>GSS</sub>	±20	±20	V	
Continuous Prais Current V = 10V	SteadyState (Note 5)	I <sub>D</sub>	3.6	-2.6	Α
Continuous Drain Current V <sub>GS</sub> = 10V	t<10s (Note 6)	I <sub>D</sub>	4.7	-3.9	Α
Maximum Body Diode Forward Current at t<10s (Note 6)	I <sub>S</sub>	3.4	-3.2	Α	
Pulsed Drain Current (300µs pulse, duty cycle = 2%)	I <sub>DM</sub>	22.2	-18.3	Α	
Pulsed Source Current (Body Diode) (300µs pulse, duty	I <sub>SM</sub>	22.2	-18.3	Α	

# Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units
Power Dissipation Linear Derating Factor (Note 5)	P <sub>D</sub>	1.25 10	W mW/°C
Power Dissipation Linear Derating Factor (Note 6)	P <sub>D</sub>	2.1 17	W mW/°C
Thermal Resistance, Junction to Ambient (Note 5)	R <sub>θJA</sub>	100	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	$R_{\theta JA}$	58	C/VV
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C





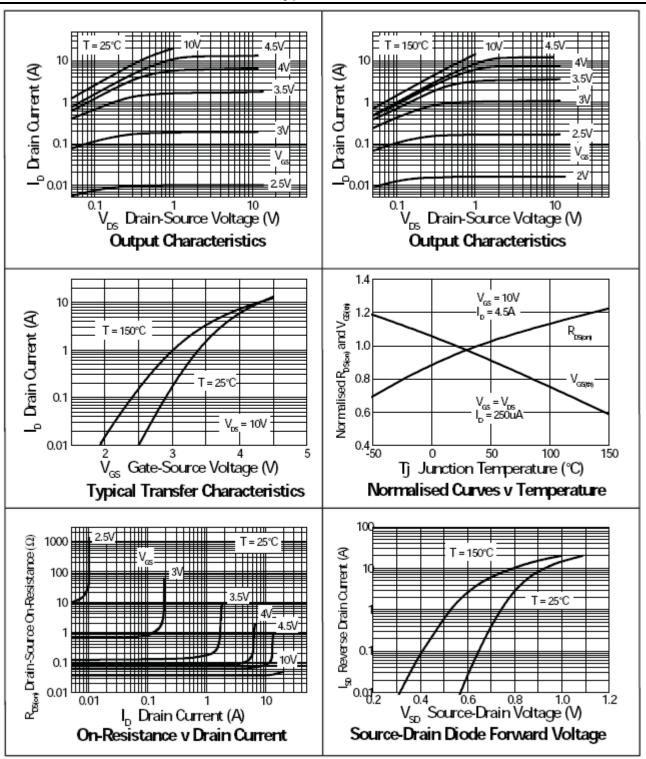


# Electrical Characteristics N-Channel Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)			·			•
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	60	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	1.0	μΑ	V <sub>DS</sub> = 60V, V <sub>GS</sub> = 0V
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V
ON CHARACTERISTICS (Note 7)			•			
Gate Threshold Voltage	V <sub>GS(th)</sub>	1.0	_	_	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance	Б	_	_	55	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 4.5A
Static Diain-Source On-Resistance	R <sub>DS(ON)</sub>	_	_	75	11122	$V_{GS} = 4.5V, I_D = 4.0A$
Diode Forward Voltage	V <sub>SD</sub>	_	0.85	1.2	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = 5.5A
Forward Transconductance	g <sub>fs</sub>	_	10.2	_	S	V <sub>DS</sub> =15V,I <sub>D</sub> =4.5A
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C <sub>iss</sub>	_	1063	_		V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V, f = 1.0MHz
Output Capacitance	Coss	_	104	_	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	_	64	_		
Total Gate Charge (V <sub>GS</sub> = 5.0V)	Qg	_	11	_		V <sub>DS</sub> = 30V, I <sub>D</sub> = 4.5A
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	20.4	_	nC	
Gate-Source Charge	Q <sub>gs</sub>	_	4.1	_	IIC	
Gate-Drain Charge	$Q_{gd}$	_	5.1	_		
Turn-On Delay Time	t <sub>D(on)</sub>	_	3.5	_		$V_{DD} = 30V, I_{D} = 1.0A$ $V_{GS} = 10V, R_{G} = 6.0\Omega$
Turn-On Rise Time	t <sub>r</sub>	_	4.1	_	nS	
Turn-Off Delay Time	t <sub>D(off)</sub>	_	26.2	_	113	
Turn-Off Fall Time	t <sub>f</sub>	_	10.6	_		
Body Diode Reverse Recovery Time	t <sub>rr</sub>	_	22	_	nS	I <sub>F</sub> = 2.2A, di/dt = 100A/μs
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	_	21.4		nC	I <sub>F</sub> = 2.2A, di/dt = 100A/µs

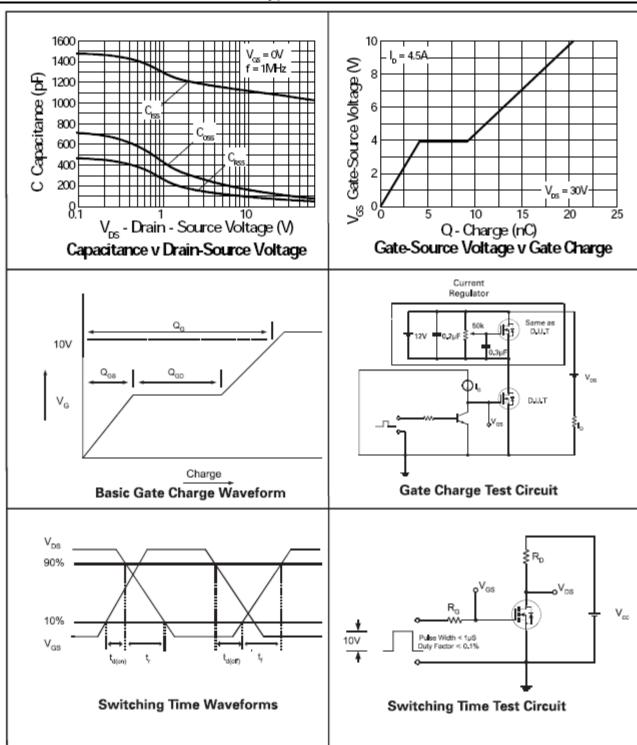


# **N-Channel Typical Characteristics**





## N-Channel Typical Characteristics (cont.)





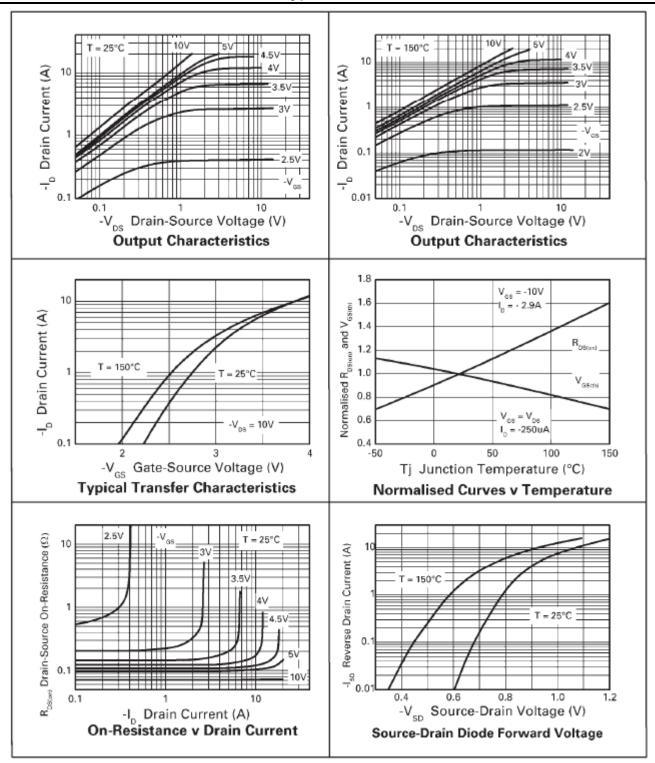
# Electrical Characteristics P-Channel Q1 (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-60	_	_	V	$V_{GS} = 0V$ , $I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	-1.0	μA	V <sub>DS</sub> = -60V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	-1.0		_	<b>V</b>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance	0	_		85	m()	$V_{GS} = -10V, I_D = -2.9A$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	_	125	mΩ	$V_{GS} = -4.5V, I_D = -2.4A$	
Diode Forward Voltage	$V_{SD}$	_	-0.85	-0.95	V	$V_{GS} = 0V$ , $I_S = -3.4A$	
Forward Transconductance	9 <sub>fs</sub>	_	7.2	_	S	V <sub>DS</sub> =-15V,I <sub>D</sub> =-2.9A	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C <sub>iss</sub>	_	1021	_	pF	V <sub>DS</sub> = -30V, V <sub>GS</sub> = 0V f = 1.0MHz	
Output Capacitance	Coss	_	83.1	_			
Reverse Transfer Capacitance	C <sub>rss</sub>	_	56.4	_			
Total Gate Charge (V <sub>GS</sub> = -5.0V)	Qg	_	12.1	_		V <sub>DS</sub> = -30V, I <sub>D</sub> = -2.9A	
Total Gate Charge (V <sub>GS</sub> = -10V)	Qg	_	24.2	_	nC		
Gate-Source Charge	Qgs	_	2.5	_	IIC	VDS = -30V, ID = -2.9A	
Gate-Drain Charge	$Q_{gd}$	_	3.7	_			
Turn-On Delay Time	t <sub>D(on)</sub>	_	3.5	_			
Turn-On Rise Time	t <sub>r</sub>	_	4.1	_	0	$V_{DD}$ = -30V, $I_{D}$ = -1.0A $V_{GS}$ = -10V, $R_{G}$ = 6.0 $\Omega$	
Turn-Off Delay Time	t <sub>D(off)</sub>	_	35	_	nS		
Turn-Off Fall Time	t <sub>f</sub>	_	10	_			
Body Diode Reverse Recovery Time	t <sub>rr</sub>	_	29.2	_	nS	I <sub>S</sub> = -2.0A, dI/dt = 100A/µs	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	_	39.6	_	nC	I <sub>S</sub> = -2.0A, dI/dt = 100A/μs	

- Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
   Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
   Short duration pulse test used to minimize self-heating effect.
   Guaranteed by design. Not subject to product testing.

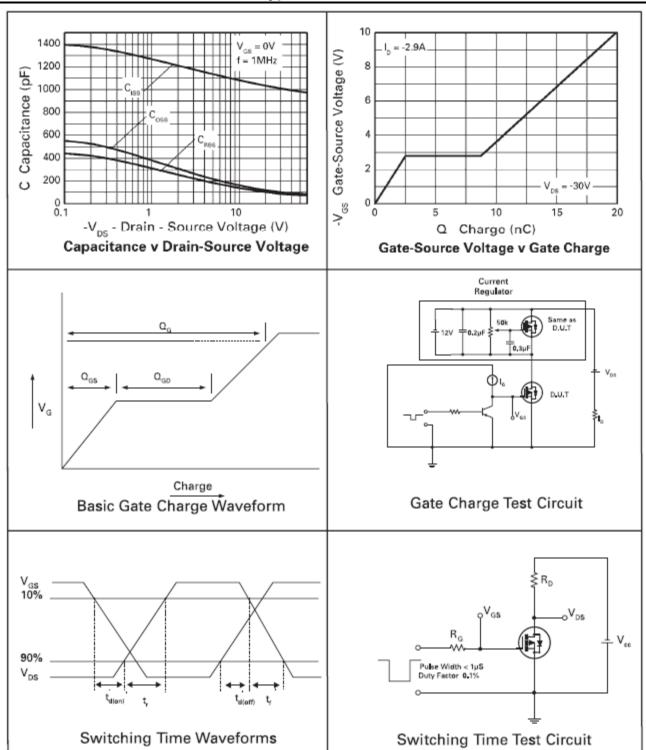


## **P-Channel Typical Characteristics**





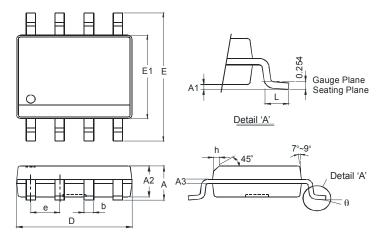
# P-Channel Typical Characteristics (cont.)





## **Package Outline Dimensions**

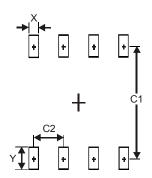
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SO-8					
Dim	Min	Max			
Α	ı	1.75			
A1	0.10	0.20			
A2	1.30	1.50			
A3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85	3.95			
е	1.27 Typ				
h	-	0.35			
L	0.62	0.82			
θ	0° 8°				
All Dimensions in mm					

## **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for latest version.



Dimensions	Value (in mm)			
Х	0.60			
Υ	1.55			
C1	5.4			
C2	1.27			



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